

Product Summary

V _{(BR)DSS}	R _{DS(on) max}	I _D T _A = +25°C
-20V	$42.5 \text{m}\Omega$ @ $V_{GS} = -4.5 \text{V}$	-4.0A
-207	$71m\Omega @ V_{GS} = -1.8V$	-2.0A

Description

This new generation MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

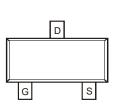
- DC-DC Converters
- Power Management Functions

Features

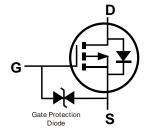
- Low On-Resistance
- Low Input Capacitance
- · Fast Switching Speed
- Low Input/Output Leakage
- ESD Protected Up To 3kV
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SOT23
- Case Material: Molded Plastic, "Green" Molding Compound.
- UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
- Solderable per MIL-STD-202, Method 208 @3
- Terminals Connections: See Diagram Below
- Weight: 0.008 grams (Approximate)



Top View Internal Schematic



Equivalent Circuit

SOT23





Top View

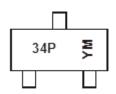
Ordering Information (Note 4)

Part Number	Compliance	Case	Packaging
DMG3415U-7	Standard	SOT23	3,000/Tape & Reel
DMG3415UQ-7	Automotive	SOT23	3,000/Tape & Reel
DMG3415U-13	Standard	SOT23	10,000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



 $\begin{array}{l} 34P = Product \ Type \ Marking \ Code \\ YM \ or \ \overline{Y}M = Date \ Code \ Marking \ for \\ Y \ or \ \overline{Y} = Year \ (ex: A = 2013) \\ M = Month \ (ex: 9 = September) \end{array}$

Date Code Key

Date Code Hoy												
Year	200	9	2010		2011	20	12	2013		2014	2	2015
Code	W		Χ		Υ		7	Α		В		С
Month	Jan	Feb	Mar	Apr	Mav	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units
Drain-Source Voltage	V_{DSS}	-20	V
Gate-Source Voltage	V _{GSS}	±8	V
Continuous Drain Current (Note 5) V _{GS} = -4.5V	I _D	-4.0 -3.5	А
Pulsed Drain Current (10µs pulse, duty cycle = 1%)	I _{DM}	-30	А

Thermal Characteristics ($@T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic	Symbol	Value	Units
Total Power Dissipation (Note 5)	P_{D}	0.9	W
Thermal Resistance, Junction to Ambient (Note 5)	$R_{\theta JA}$	139	°C/W
Thermal Resistance, Junction to case (Note 5)	$R_{\theta JC}$	32	°C/W
Operating and Storage Temperature Range	T _{J,} T _{STG}	-55 to +150	°C

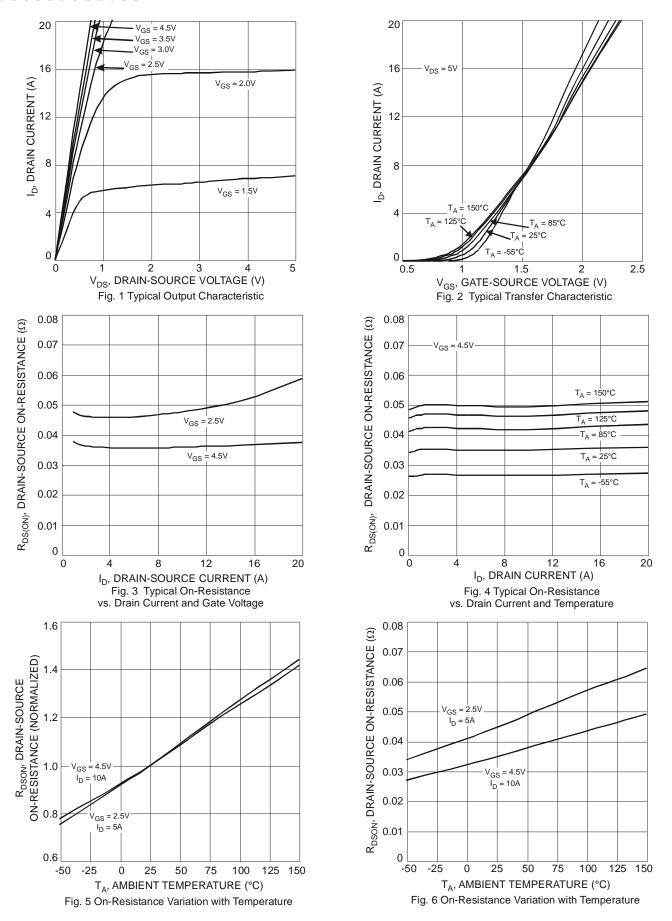
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)						
Drain-Source Breakdown Voltage	BV _{DSS}	-20	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}		_	-1	μΑ	V _{DS} = -20V, V _{GS} = 0V
Gate-Source Leakage	IGSS	_	_	±10	μΑ	$V_{GS} = \pm 8.0V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 6)						
Gate Threshold Voltage	V _{GS(th)}	-0.3	-0.55	-1.0	V	$V_{DS} = V_{GS}$, $I_D = -250\mu A$
		1	31	42.5		$V_{GS} = -4.5V, I_D = -4.0A$
Static Drain-Source On-Resistance	R _{DS(ON)}	_	40	53	mΩ	$V_{GS} = -2.5V, I_D = -3.5A$
		_	51	71		$V_{GS} = -1.8V, I_D = -2.0A$
Forward Transfer Admittance	g _{FS}	_	3	_	S	$V_{DS} = -5V, I_{D} = -4A$
DYNAMIC CHARACTERISTICS (Note 7)						
Input Capacitance	C _{iss}		294	_	pF	
Output Capacitance	Coss	_	104	_	pF	$V_{DS} = -10V$, $V_{GS} = 0V$ f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	_	25	_	pF	1 - 1.000112
Gate Resistnace	Rg	_	250	_	Ω	$V_{DS} = 0V$, $VGS = 0V$, $f = 1.0MHz$
SWITCHING CHARACTERISTICS (Note 7)						
Total Gate Charge	Q_g	1	9.1	_	nC	
Gate-Source Charge	Q_{gs}	_	1.5	_	nC	$V_{GS} = -4.5V, V_{DS} = -10V$ $I_{D} = -4A$
Gate-Drain Charge	Q_{gd}	_	1.7	_	nC	1D = -4/A
Turn-On Delay Time	t _{D(on)}	_	71	_	ns	
Turn-On Rise Time	t _r	_	117	_	ns	$V_{DS} = -10V, V_{GS} = -4.5V,$
Turn-Off Delay Time	t _{D(off)}		795	_	ns	$R_D = 2.5\Omega$, $R_G = 3.0\Omega$, $I_D = -1A$
Turn-Off Fall Time	t _f		393	_	ns	

Notes:

- 5. Device mounted on FR-4 substrate PC board, with minimum recommended pad layout.
- Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to production testing.







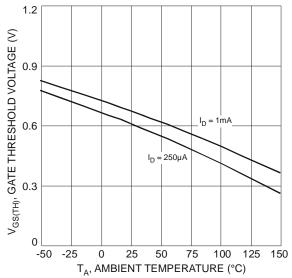


Fig. 7 Gate Threshold Variation vs. Ambient Temperature

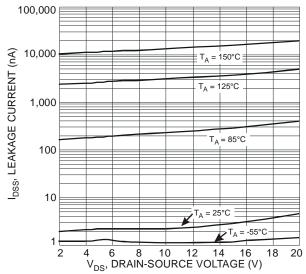
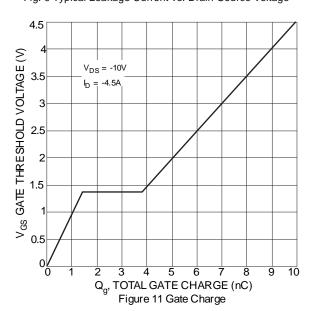
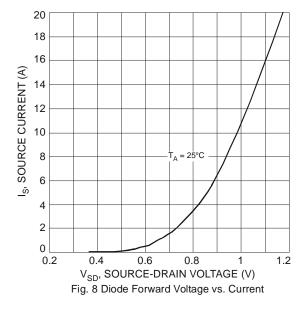


Fig. 9 Typical Leakage Current vs. Drain-Source Voltage





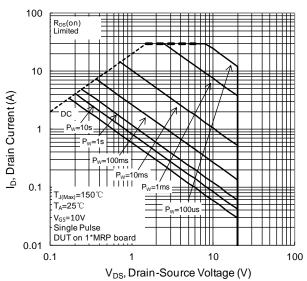
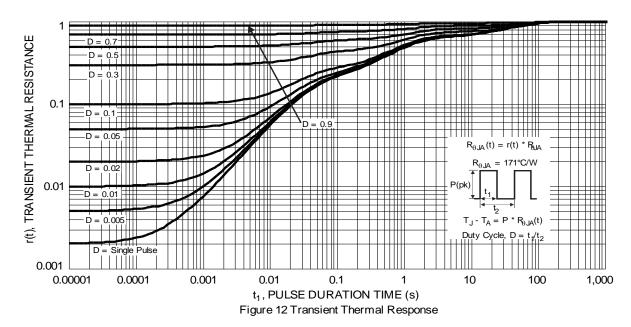


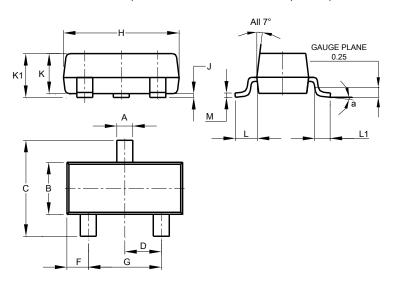
Fig. 10 SOA, Safe Operation Area





Package Outline Dimensions

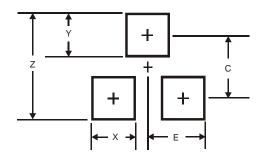
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.



SOT23							
Dim	Min	Max	Тур				
Α	0.37	0.51	0.40				
В	1.20	1.40	1.30				
C	2.30	2.50	2.40				
D	0.89	1.03	0.915				
F	0.45	0.60	0.535				
G	1.78	2.05	1.83				
Н	2.80	3.00	2.90				
J	0.013	0.10	0.05				
K	0.890	1.00	0.975				
K1	0.903	1.10	1.025				
L	0.45	0.61	0.55				
L1	0.25	0.55	0.40				
М	0.085	0.150	0.110				
а	8°						
All Dimensions in mm							

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)			
Z	2.9			
Х	0.8			
Y	0.9			
С	2.0			
E	1.35			

January 2015

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Document number: DS31735 Rev. 12 - 2 www.diodes.com